## **CLAIMS**

65. (Currently Amended) A method of carrying out at least two processing steps on a workpiece, the method comprising the steps of:

lowering the workpiece into a lower section of the a chamber;

carrying out a first processing step to remove conductive material from on the workpiece in the lower section of the chamber;

raising the workpiece from the lower section to an upper section of the chamber; positioning a movable guard between the lower section and the upper section; and carrying out a second processing step on the workpiece in the upper section.

- 66. (Currently Amended) A method according to claim 65, wherein the first processing step comprises one of depositing on, polishing[,] and etching, and modifying the conductive material from a surface on the workpiece.
- 67. (Original) A method according to claim 65, wherein the second processing step comprises one of rinsing, cleaning, depositing on, etching, modifying, and drying a surface on the workpiece.
  - 68. (Currently Amended) A method of carrying out alt least two processing steps on a workpiece, the method comprising the steps of:

carrying out a second processing step on the workpiece in an upper section after positioning a movable guard between the upper section and a lower section of the a chamber;

repositioning the movable guard such that the workpiece can be lowered into the lower section of the chamber;

lowering the workpiece into the lower section of the chamber; and carrying out a first processing step on the workpiece in the lower section of the chamber.

- 69. (Currently Amended) A method according to claim 68 76, wherein the first processing step comprises one of depositing on, polishing[,] and etching, and modifying the conductive material from a surface on the workpiece.
- 70. (Original) A method according to claim 68, wherein the second processing step comprises one of rinsing, cleaning, depositing on, etching, modifying, and drying a surface on the workpiece.
- 71. (Original) A method according to claim 70, wherein the step of etching or modifying further comprises the step of providing a gas to the surface of the workpiece from a group consisting essentially of O<sub>2</sub>, CF<sub>4</sub>, Cl<sub>2</sub>, and NH<sub>2</sub>.
- 72. (Original) A method according to claim 71 further comprising the step of heating the workpiece while the gas is provided to the surface of the workpiece.
- 73. (New) A method according to claim 65, wherein the first processing step further includes the step of electro chemically depositing the conductive material on the workpiece.
- 74. (New) A method according to claim 65, wherein the first processing step electro chemically removes the conductive material from the workpiece.
- 75. (New) A method according to claim 65, wherein the second processing step comprises the step of chemically etching the workpiece in the upper section.
  - 76. (New) The method of claim 68 wherein the step of carrying out the first processing step includes removing conductive material from the workpiece in the lower section of the chamber.
- 77. (New) A method according to claim 76, wherein the first processing step further includes the step of electro chemically depositing the conductive material on the workpiece.

10/041,029

- 78. (New) A method according to claim 76, wherein the first processing step electro chemically removes the conductive material from the workpiece.
- 79. (New) A method of processing a workpiece using a vertical multi-chambered processing module comprising the steps:

removing conductive material from the workpiece in a first chamber;
transferring the workpiece to a second chamber vertically disposed with respect to
the first chamber;

isolating the first chamber from the second chamber; and modifying the workpiece in the second chamber.

- 80. (New) A method of claim 79, wherein the removing step further includes the step of depositing a material on the workpiece.
- 81. (New) A method of claim 79, wherein the removing step further includes the step of electro chemically mechanically depositing a conductive material on the workpiece.
- 82. (New) A method of claim 79, wherein the removing step includes polishing the conductive material from the workpiece.
- 83. (New) The method of claim 79, wherein the removing step includes electro chemically removing a conductive material from the workpiece.
- 84. (New) The method of claim 79, wherein the modifying step includes cleaning a surface of the workpiece.
- 85. (New) The method of claim 79, wherein the modifying step includes chemically etching a surface of the workpiece.

- 86. (New) The method of claim 79 wherein the step of removing conductive material from the workpiece in a first chamber is performed so that a surface of the workpiece being operated upon is disposed in a substantially horizontal orientation.
- 87. (New) The method of claim 65 wherein the first process step in the lower chamber is performed so that a surface of the workpiece being operated upon is disposed in a substantially horizontal orientation.
- 88. (New) The method of claim 68 wherein the first process step in the lower chamber is performed so that a surface of the workpiece being operated upon is disposed in a substantially horizontal orientation.